

Search Notes

Application/Control No.

10/783,022

Examiner

Hwei-Siu C. Payer

Applicant(s)/Patent under
Reexamination

SHIRAISHI ET AL.

Art Unit

3724

SEARCHED

Class	Subclass	Date	Examiner
030	90.1	11-2-05	Payer
	91.2		
	94		
	123		
	253		
	234		
	345		
	90.4		
	90.6		
	279.2		
	278		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (see search history printout)	11-2-05	Payer

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner